## Notice of References Cited

Application/Control No.

10/047,266

Examiner

Kin-Chan Chen

Applicant(s)/Patent Under
Reexamination
KE ET AL.

Art Unit
Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,804,088	09-1998	McKee, Jeffrey Alan	216/47
	В	US-6,117,622	09-2000	Eisele et al.	430/328
	С	US-5,976,769	11-1999	Chapman, Richard Alexander	430/316
	D	US-6,420,098	07-2002	Mautz, Karl	430/313
	Е	US-6,528,229	03-2003	Sato, Kenichiro	430/170
	F	US-6,433,878	08-2002	Niu et al.	356/603
	G	US-6,368,974	04-2002	Tsai et al.	438/695
	Н	US-			
	ı	US-			
	٦	US-			
	к	US-			
	L	US-			
$\Box$	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

	NON-FAIENT DOCUMENTS						
*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	x						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.